

Notice of References Cited	Application/Control No. 08/939,442	Applicant(s)/Patent Under Reexam Na et al	
	Examiner Christopher Onuaku	Art Unit 2615	Page 1 of 1

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NON-PATENT DOCUMENTS

*	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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¹ copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

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² Classifications may be U.S. or foreign.